MIC4103/4104

100V Half-Bridge MOSFET Drivers with 3A/2A Sinking/Sourcing Current

General Description

The MIC4103 and MIC4104 are high-frequency, 100V half-bridge MOSFET drivers with faster turn-off characteristics than the MIC4100 and MIC4101 drivers. They feature fast 24ns propagation delay times and 6ns driver fall times. The low-side and high-side gate drivers are independently controlled and matched to within 3ns (typical). The MIC4103 has CMOS input thresholds and the MIC4104 has TTL input thresholds. The MIC4103/4 include a high-voltage internal diode that charges the high-side gate drive bootstrap capacitor.

A robust, high-speed, and low-power level shifter provides clean level transitions to the high-side output. The robust operation of the MIC4103/4 ensures the outputs are not affected by supply glitches, HS ringing below ground, or HS slewing with high-speed voltage transitions. Undervoltage protection is provided on both the low-side and high-side drivers.

The MIC4103 and MIC4104 are available in an 8-pin SOIC package with an operating junction temperature range of –40°C to +125°C.

Datasheets and support documentation are available on Micrel's web site at: www.micrel.com.

Features

- Asymmetrical, low impedance outputs drive 1000pF load with 10ns rise times and 6ns fall times
- Bootstrap supply maximum voltage to 118V DC
- Supply voltage up to 16V
- Drives high and low-side N-Channel MOSFETs with independent inputs
- CMOS input thresholds (MIC4103)
- TTL input thresholds (MIC4104)
- On-chip bootstrap diode
- Fast 24ns propagation times
- Low power consumption
- Supply undervoltage protection
- Typical 2.5Ω pull-up and 1.25Ω pull-down output driver resistance
- –40°C to +125°C junction temperature range

Applications

- High-voltage buck converters
- Full- and half-bridge power topologies
- Active clamp forward converter
- Two switch forward topologies
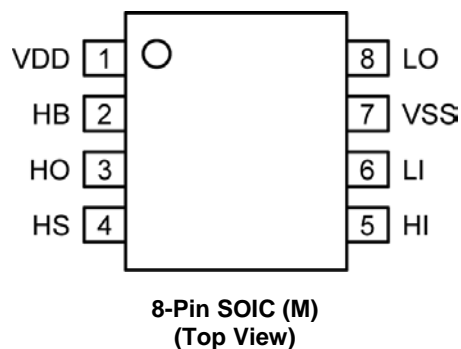- Interface to digital controllers

Typical Application
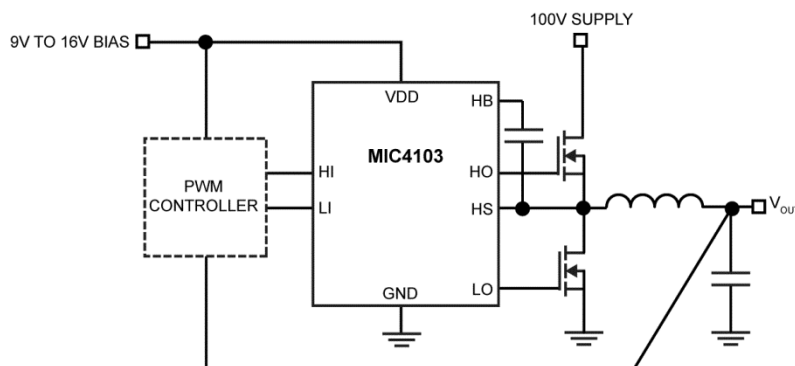
100V Buck Regulator Solution

Ordering Information

Part Number	Input	Junction Temperature Range	Package
MIC4103YM	CMOS	−40° to +125°C	8-Pin SOIC
MIC4104YM	TTL	−40° to +125°C	8-Pin SOIC

Pin Configuration

8-Pin SOIC (M)
(Top View)

Pin Description

Pin Number	Pin Name	Pin Function
1	VDD	Positive Supply to lower gate drivers. Decouple this pin to VSS (Pin 7). Bootstrap diode connected to HB (pin 2).
2	HB	High-Side Bootstrap supply. External bootstrap capacitor is required. Connect positive side of bootstrap capacitor to this pin. Bootstrap diode is on-chip.
3	HO	High-Side Output. Connect to gate of High-Side power MOSFET.
4	HS	High-Side Source connection. Connect to source of High-Side power MOSFET. Connect negative side of bootstrap capacitor to this pin.
5	HI	High-Side input.
6	LI	Low-Side input.
7	VSS	Chip negative supply, generally will be ground.
8	LO	Low-Side Output. Connect to gate of Low-Side power MOSFET.

Absolute Maximum Ratings[1]

Supply Voltage (V_{DD}, V_{HB} − V_{HS}) .... −0.3V to 18V
Input Voltages (V_{LI}, V_{HI}) .... −0.3V to V_{DD} + 0.3V
Voltage on LO (V_{LO}) .... −0.3V to V_{DD} + 0.3V
Voltage on HO (V_{HO}) .... V_{HS} − 0.3V to V_{HB} + 0.3V
Voltage on HS (continuous) .... −1V to 110V
Voltage on HB 118V
Average Current in VDD to HB Diode 100mA
Junction Temperature (T_J) ....−55°C to +150°C
Storage Temperature (T_s) ....−60°C to +150°C
ESD Rating...Note 3

Operating Ratings[2]

Supply Voltage (V_{DD}).. +9V to +16V
Voltage on HS .... −1V to 100V
Voltage on HS (repetitive transient) .... −5V to 105V
HS Slew Rate..50V/ns
Voltage on HB and
     VHS ....V_{HS} + 8V to V_{HS} + 16V
     VDD .... V_{DD} - 1V to V_{DD} + 100V
Junction Temperature (T_J) ....−40°C to +125°C
Junction Thermal Resistance
     SOIC-8L (θ_{JA})..140°C/W

Electrical Characteristics[4, 5]

V_{DD} = V_{HB} = 12V; V_{SS} = V_{HS} = 0V; No load on LO or HO; T_A = +25°C; unless noted. **Bold** values indicate −40°C ≤ TJ ≤ +125°C.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
Supply Current						
I_{DD}	V_{DD} Quiescent Current	LI = HI = 0V		40	150 **200**	µA
I_{DDO}	V_{DD} Operating Current	f = 500kHz		3.0	**4.0**	mA
I_{HB}	Total HB Quiescent Current	LI = HI = 0V		25	150 **200**	µA
I_{HBO}	Total HB Operating Current	f = 500kHz		1.5	2.5 **3**	mA
I_{HBS}	HB to V_{SS} Current, Quiescent	V_{HS} = V_{HB} = 110V		0.05	1 **30**	µA
Input Pins: MIC4103 (CMOS Input)						
V_{IL}	Low-Level Input Voltage Threshold		4 **3**	5.3		V
V_{IH}	High-Level Input Voltage Threshold			5.7	7 **8**	V
V_{IHYS}	Input Voltage Hysteresis			0.4		V
R_I	Input Pull-Down Resistance		**100**	200	**500**	kΩ
Input Pins: MIC4104 (TTL Input)						
V_{IL}	Low-Level Input Voltage Threshold		**0.8**	1.5		V
V_{IH}	High-Level Input Voltage Threshold			1.5	**2.2**	V
R_I	Input Pull-Down Resistance		**100**	200	**500**	kΩ
Undervoltage Protection						
V_{DDR}	V_{DD} Rising Threshold		**6.5**	7.4	**8.0**	V
V_{DDH}	V_{DD} Threshold Hysteresis			0.5		V
V_{HBR}	HB Rising Threshold		**6.0**	7.0	**8.0**	V
V_{HBH}	HB Threshold Hysteresis			0.4		V

Notes:

1. Exceeding the absolute maximum ratings may damage the device.

2. The device is not guaranteed to function outside its operating ratings.

3. Devices are ESD sensitive. Handling precautions are recommended. Human body model, 1.5kΩ in series with 100pF.

4. Specification for packaged product only

Electrical Characteristics[4, 5] (Continued)

$V_{DD} = V_{HB} = 12V$; $V_{SS} = V_{HS} = 0V$; No load on LO or HO; $T_A = +25°C$; unless noted. **Bold** values indicate $-40°C \leq TJ \leq +125°C$.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
Bootstrap Diode						
V_{DL}	Low-Current Forward Voltage	$I_{VDD-HB} = 100\mu A$		0.4	0.55 **0.70**	V
V_{DH}	High-Current Forward Voltage	$I_{VDD-HB} = 100mA$		0.7	0.8 **1.0**	V
R_D	Dynamic Resistance	$I_{VDD-HB} = 100mA$		1.0	1.5 **2.0**	Ω
LO Gate Driver						
V_{OLL}	Low-Level Output Voltage	$I_{LO} = 160mA$		0.18	0.3 **0.4**	V
V_{OHL}	High-Level Output Voltage	$I_{LO} = -100mA$, $V_{OHL} = V_{DD} - V_{LO}$		0.25	0.3 **0.45**	V
I_{OHL}	Peak Sink Current	$V_{LO} = 0V$		3		A
I_{OLL}	Peak Source Current	$V_{LO} = 12V$		2		A
HO Gate Driver						
V_{OLH}	Low-Level Output Voltage	$I_{HO} = 160mA$		0.22	0.3 **0.4**	V
V_{OHH}	High-Level Output Voltage	$I_{HO} = -100mA$, $V_{OHH} = V_{HB} - V_{HO}$		0.25	0.3 **0.45**	V
I_{OHH}	Peak Sink Current	$V_{HO} = 0V$		3		A
I_{OLH}	Peak Source Current	$V_{HO} = 12V$		2		A
Switching Specifications						
t_{LPHL}	Lower Turn-Off Propagation Delay (LI Falling to LO Falling)	(MIC4103)		24	**45**	ns
t_{HPHL}	Upper Turn-Off Propagation Delay (HI Falling to HO Falling)	(MIC4103)		24	**45**	ns
t_{LPLH}	Lower Turn-On Propagation Delay (LI Rising to LO Rising)	(MIC4103)		24	**45**	ns
t_{HPLH}	Upper Turn-On Propagation Delay (HI Rising to HO Rising)	(MIC4103)		24	**45**	ns
t_{LPHL}	Lower Turn-Off Propagation Delay (LI Falling to LO Falling)	(MIC4104)		24	**45**	ns
t_{HPHL}	Upper Turn-Off Propagation Delay (HI Falling to HO Falling)	(MIC4104)		24	**45**	ns
t_{LPLH}	Lower Turn-On Propagation Delay (LI Rising to LO Rising)	(MIC4104)		24	**45**	ns
t_{HPLH}	Upper Turn-On Propagation Delay (HI Rising to HO Rising)	(MIC4104)		24	**45**	ns
t_{MON}	Delay Matching: Lower Turn-On and Upper Turn-Off			3	8 **10**	ns
t_{MOFF}	Delay Matching: Lower Turn-Off and Upper Turn-On			3	8 **10**	ns
t_{RC}	Output Rise Time	$C_L = 1000pF$		10		ns
t_{FC}	Output Fall Time	$C_L = 1000pF$		6		ns

Electrical Characteristics[4, 5] (Continued)

$V_{DD} = V_{HB} = 12V$; $V_{SS} = V_{HS} = 0V$; No load on LO or HO; $T_A = +25°C$; unless noted. **Bold** values indicate $-40°C \leq TJ \leq +125°C$.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
Switching Specifications (Continued)						
t_R	Output Rise Time (3V to 9V)	$C_L = 0.1\mu F$		0.4	0.6 **0.8**	µs
t_F	Output Fall Time (3V to 9V)	$C_L = 0.1\mu F$		0.2	0.3 **0.4**	µs
t_{PW}	Minimum Input Pulse Width that Changes the Output	**Note 6**			**50**	ns
t_{BS}	Bootstrap Diode Turn-On or Turn-Off Time			10		ns

Notes:

5. All voltages relative to Pin 7, V_{SS} unless otherwise specified

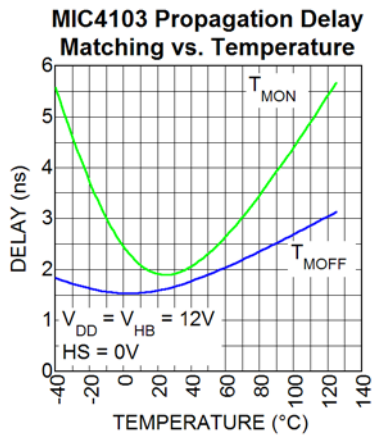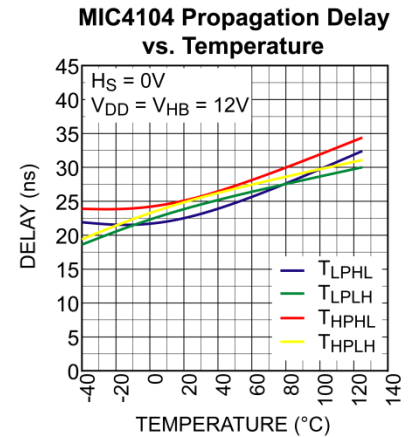6. Guaranteed by design. Not production tested.

Timing Diagrams
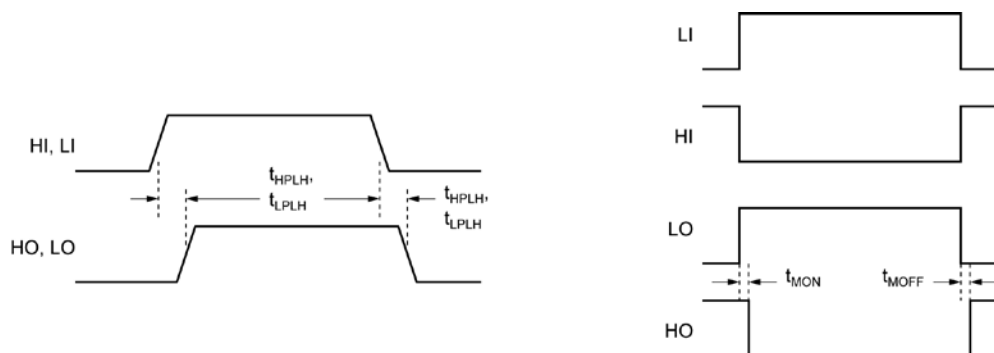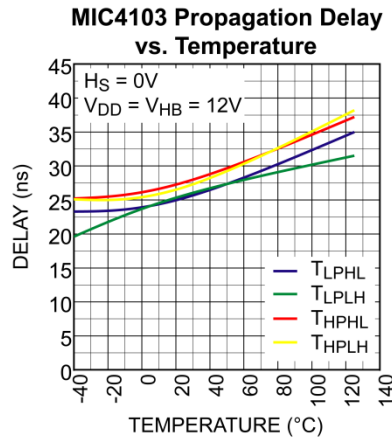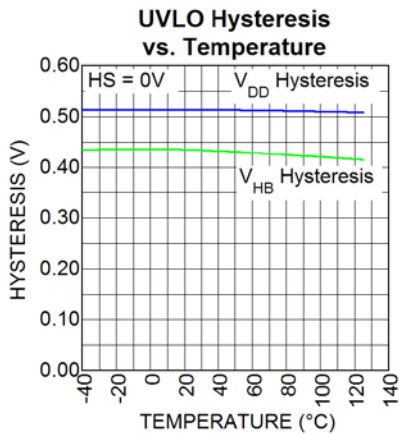

Note:

All propagation delays are measured from the 50% voltage level.

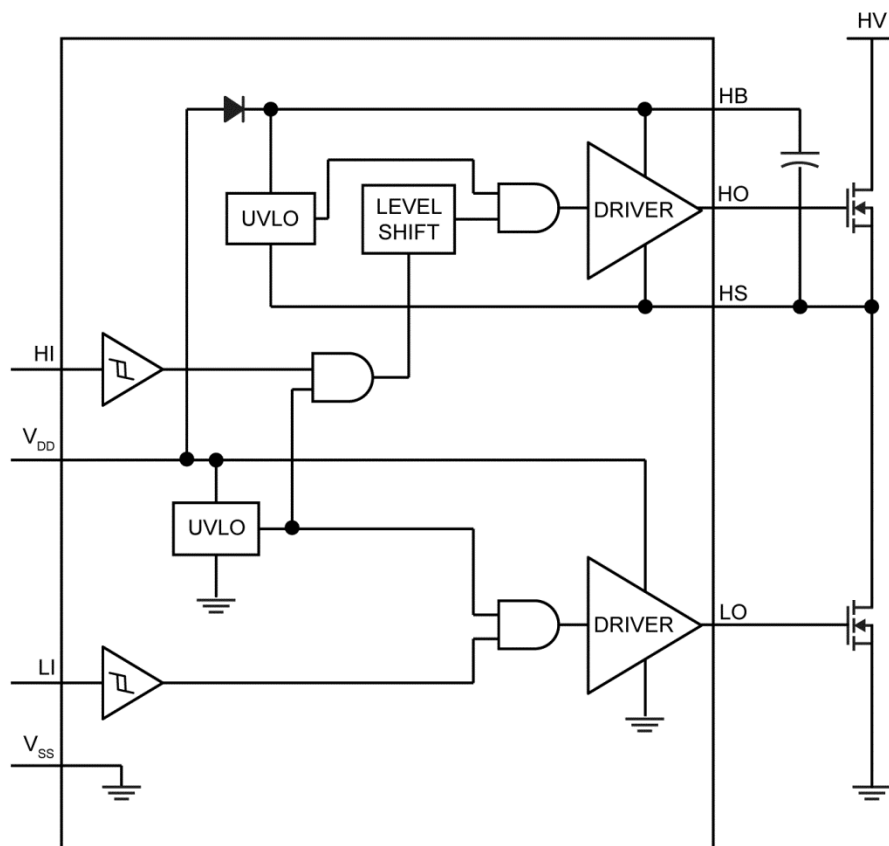# Typical Characteristics
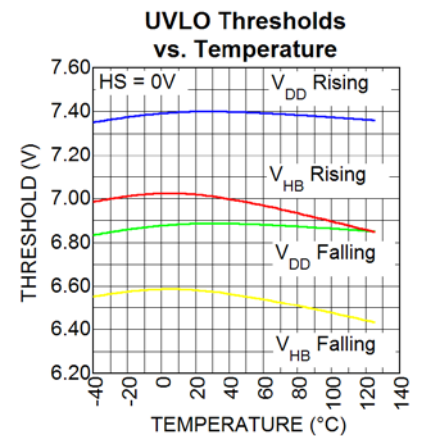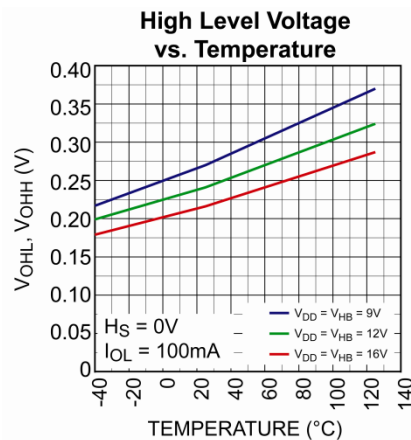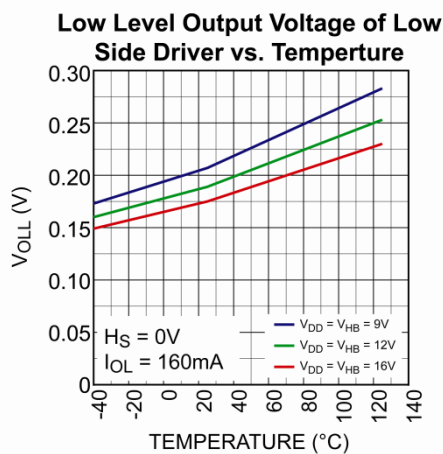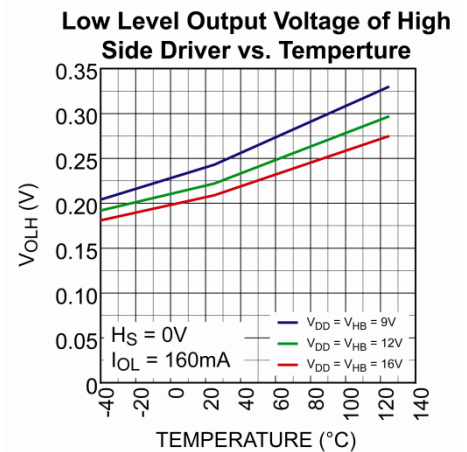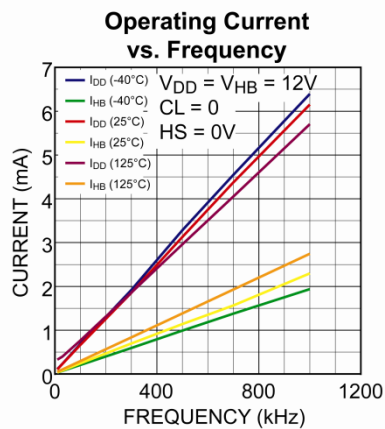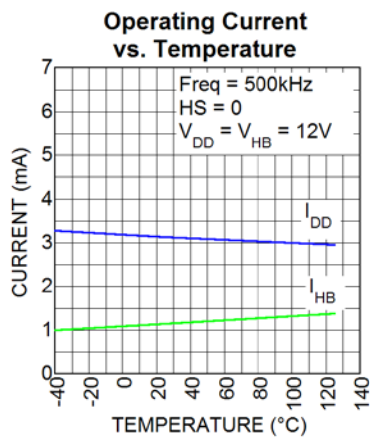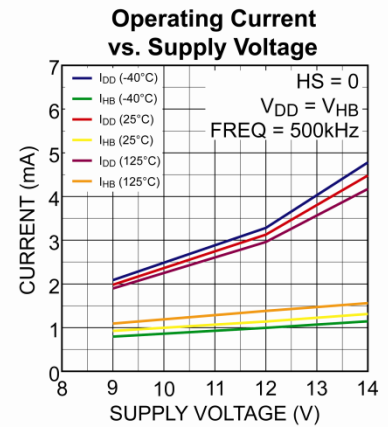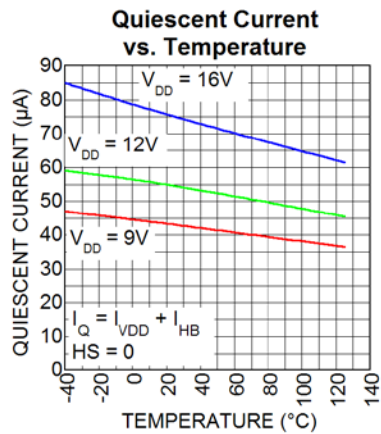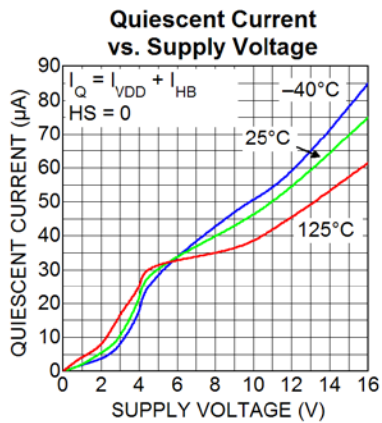
Typical Characteristics (Continued)

UVLO Hysteresis vs. Temperature

MIC4103 Propagation Delay vs. Temperature

MIC4104 Propagation Delay vs. Temperature

MIC4103 Propagation Delay Matching vs. Temperature

MIC4104 Propagation Delay vs. Temperature

MIC4103 Propagation Delay vs. Supply Voltage

MIC4104 Propagation Delay vs. Supply Voltage

Bootstrap Diode I-V Characteristics

Bootstrap Diode Reverse Current

Functional Diagram

Functional Description

The MIC4103 is a high-voltage, non-inverting, dual MOSFET driver that is designed to independently drive both high-side and low-side N-Channel MOSFETs. The block diagram of the MIC4103 is shown in the *Functional Diagram*.

Both drivers contain an input buffer with hysteresis, a UVLO circuit and an output buffer. The high-side output buffer includes a high-speed level-shifting circuit that is referenced to the HS pin. An internal diode is used as part of a bootstrap circuit to provide the drive voltage for the high-side output.

Startup and UVLO

The UVLO circuit forces the driver output low until the supply voltage exceeds the UVLO threshold. The low-side UVLO circuit monitors the voltage between the VDD and VSS pins. The high-side UVLO circuit monitors the voltage between the HB and HS pins. Hysteresis in the UVLO circuit prevents noise and finite circuit impedance from causing chatter during turn-on.

Input Stage

The MIC4103 and MIC4104 have different input stages, which lets these parts cover a wide range of driver applications. Both the HI and LI pins are referenced to the VSS pin.

The MIC4103 has a high-impedance, CMOS compatible input threshold and is recommended for applications where the input signal is noisy or where the input signal swings the full range of voltage (from V_{DD} to GND). There is typically 400mV of hysteresis on the input pins throughout the V_{DD} range. The hysteresis improves noise immunity and prevents input signals with slow rise times from falsely triggering the output. The threshold voltage of the MIC4103 varies proportionally with the V_{DD} supply voltage.

The amplitude of the input signal affects the VDD supply current. V_{IN} voltages that are a diode drop less than the V_{DD} supply voltage will cause an increase in the VDD pin current. The graph in Figure 1 shows the typical dependence between I_{VDD} and V_{IN} for V_{DD} = 12V.
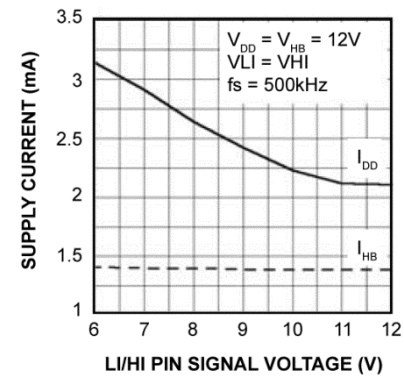

Figure 1. MIC4103 Supply Current vs. Input Voltage

The MIC4104 has a TTL compatible input range and is recommended for use with inputs signals whose amplitude is less than the supply voltage. The threshold level is independent of the VDD supply voltage and there is no dependence between I_{VDD} and the input signal amplitude with the MIC4104. This feature makes the MIC4104 an excellent level translator that will drive high threshold MOSFETs from a low voltage PWM IC.

Low-Side Driver

A block diagram of the low-side driver is shown in Figure 2. The low-side driver is designed to drive a ground (VSS pin) referenced N-channel MOSFET. Low driver impedances allow the external MOSFET to be turned on and off quickly. The rail-to-rail drive capability of the output ensures full enhancement of the external MOSFET.

A high level applied to LI pin causes the upper driver FET to turn on and V_{DD} voltage is applied to the gate of the external MOSFET. A low level on the LI pin turns off the upper driver and turns on the low side driver to ground the gate of the external MOSFET.
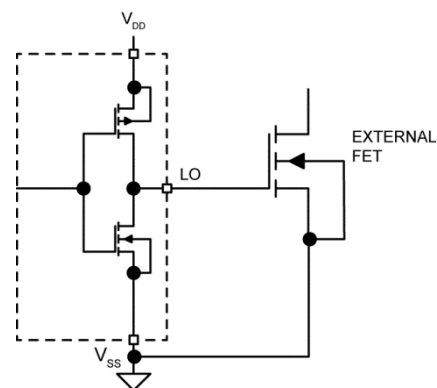

Figure 2. Low-Side Driver Block Diagram

High-Side Driver and Bootstrap Circuit

A block diagram of the high-side driver and bootstrap circuit is shown in Figure 3. This driver is designed to drive a floating N-channel MOSFET, whose source terminal is referenced to the HS pin.
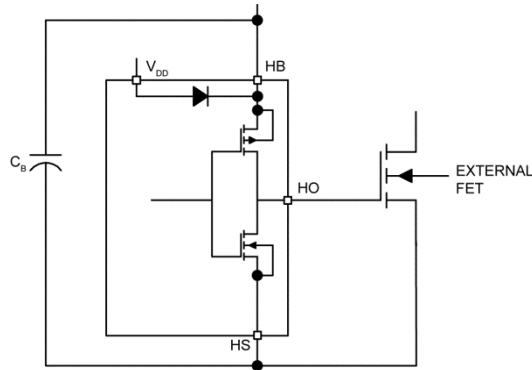

Figure 3. High-Side Driver and Bootstrap Circuit Block Diagram

A low-power, high-speed, level shifting circuit isolates the low-side (VSS pin) referenced circuitry from the high-side (HS pin) referenced driver. Power to the high-side driver and UVLO circuit is supplied by the bootstrap circuit while the voltage level of the HS pin is shifted high.

The bootstrap circuit consists of an internal diode and external capacitor, C_B. In a typical application, such as the synchronous buck converter shown in Figure 4, the HS pin is at ground potential while the low-side MOSFET is on. The internal diode allows capacitor C_B to charge up to $V_{DD} - V_D$ during this time (where V_D is the forward voltage drop of the internal diode). After the low-side MOSFET is turned off and the HO pin turns on, the voltage across capacitor C_B is applied to the gate of the upper external MOSFET. As the upper MOSFET turns on, voltage on the HS pin rises with the source of the high-side MOSFET until it reaches V_{IN}. As the HS and HB pin rise, the internal diode is reverse biased preventing capacitor C_B from discharging.
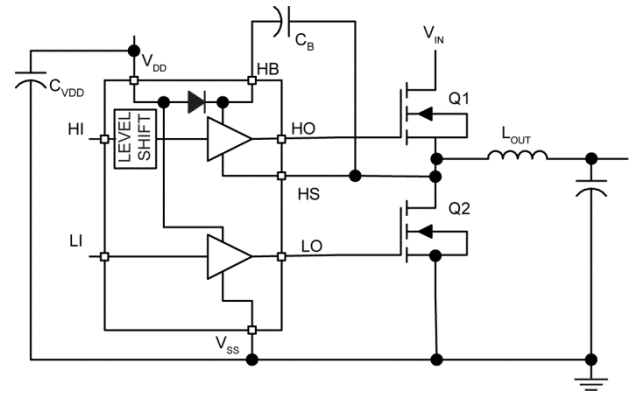

Figure 4. High-Side Driver and Bootstrap Circuit

Power Dissipation Considerations

Power dissipation in the driver can be separated into three areas:

- Internal diode dissipation in the bootstrap circuit
- Internal driver dissipation
- Quiescent current dissipation used to supply the internal logic and control functions.

Bootstrap Circuit Power Dissipation

Power dissipation of the internal bootstrap diode primarily comes from the average charging current of the C_B capacitor times the forward voltage drop of the diode. Secondary sources of diode power dissipation are the reverse leakage current and reverse recovery effects of the diode.

The average current drawn by repeated charging of the high-side MOSFET is calculated by Equation 1:

$$I_{F(AVE)} = Q_{GATE} \times f_S \qquad \text{Eq. 1}$$

Where:

Q_{GATE} = Total Gate charge at V_{HB}

f_S = Gate drive switching frequency

The average power dissipated by the forward voltage drop of the diode equals as shown in Equation 2:

$$P_{DIODE_{FWD}} = I_{F(AVE)} \times V_F \qquad \text{Eq. 2}$$

Where:

V_F = Diode-forward voltage drop.

The value of V_F should be taken at the peak current through the diode; however, this current is difficult to calculate because of differences in source impedances. The peak current can either be measured or the value of V_F at the average current can be used and will yield a good approximation of diode power dissipation.

The reverse leakage current of the internal bootstrap diode is typically 11µA at a reverse voltage of 100V and 125°C. Power dissipation due to reverse leakage is typically much less than 1mW and can be ignored.

Reverse recovery time is the time required for the injected minority carriers to be swept away from the depletion region during turn-off of the diode. Power dissipation due to reverse recovery can be calculated by computing the average reverse current due to reverse recovery charge times the reverse voltage across the diode.

Application Information

The average reverse current and power dissipation due to reverse recovery can be estimated by:

$$I_{RR(AVE)} = 0.5 \times t_{ff} \times f_S$$

$$P_{DIODE_{RR}} = I_{RR(AVE)} \times V_{REF} \qquad \text{Eq. 3}$$

Where:

IRRM = Peak reverse recovery current

The total diode power dissipation is:

$$P_{DIODE_{TOTAL}} = P_{DIODEFWD} + P_{DIODERR} \qquad \text{Eq. 4}$$

An optional external bootstrap diode may be used instead of the internal diode (Figure 5). An external diode may be useful if high gate charge MOSFETs are being driven and the power dissipation of the internal diode is contributing to excessive die temperatures. The voltage drop of the external diode must be less than the internal diode for this option to work. The reverse voltage across the diode will be equal to the input voltage minus the V_{DD} supply voltage. A 100V Schottky diode will work for most 72V input telecom applications. The above equations can be used to calculate power dissipation in the external diode, however, if the external diode has significant reverse leakage current, the power dissipated in that diode due to reverse leakage can be calculated as:

$$P_{DIODE_{REV}} = I_R \times V_{REV} \times (1 - D) \qquad \text{Eq. 5}$$

Where:

I_R = Reverse current flow at V_{REV} and T_J

V_{REV} = Diode reverse voltage

D = Duty cycle = t_{ON} / f_S

f_S = Power supply switching frequency

The on-time is the time the high-side switch is conducting. In most power supply topologies, the diode is reverse biased during the switching cycle off-time.
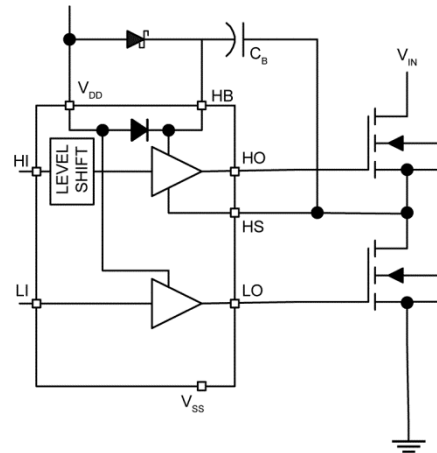

Figure 5. Optional Bootstrap Diode

Gate Driver Power Dissipation

Power dissipation in the output driver stage is mainly caused by charging and discharging the gate to source and gate to drain capacitance of the external MOSFET. Figure 6 shows a simplified equivalent circuit of the MIC4103 driving an external MOSFET.
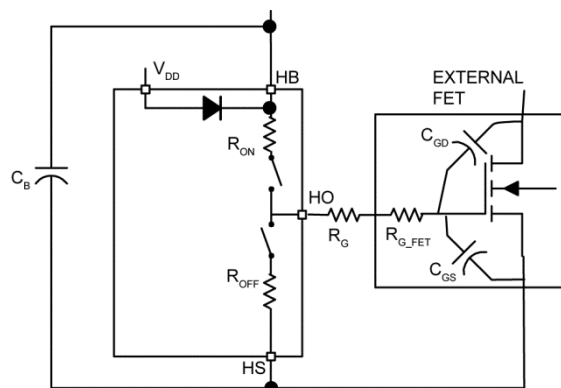

Figure 6. MIC4103 Driving an External MOSFET

Dissipation during the External MOSFET Turn-On

Energy from capacitor C_B is used to charge up the input capacitance of the MOSFET (C_{GD} and C_{GS}). The energy delivered to the MOSFET is dissipated in the three resistive components, R_{ON}, R_G, and R_{G_FET}. R_{ON} is the on resistance of the upper driver MOSFET in the MIC4103. R_G is the series resistor (if any) between the driver IC and the MOSFET. R_{G_FET} is the gate resistance of the MOSFET. R_{G_FET} is usually listed in the power MOSFET's specifications. The ESR of capacitor C_B and the resistance of the connecting trace can be ignored since they are much less than R_{ON} and R_{G_FET}.

The effective capacitance of C_{GD} and C_{GS} is difficult to calculate since they vary non-linearly with I_D, V_{GS}, and V_{DS}.

Fortunately, most power MOSFET specifications include a typical graph of total gate charge vs. V_{GS}. Figure 7 shows a typical gate charge curve for an arbitrary power MOSFET. This chart shows that for a gate voltage of 10V, the MOSFET requires about 23.5nC of charge. The energy dissipated by the resistive components of the gate drive circuit during turn-on is calculated as:

$$E = \frac{1}{2} \times C_{ISS} \times V_{GS}{}^2 \qquad \text{Eq. 6}$$

but,

$Q = C \times V$

so,

$$E = \frac{1}{2} \times Q_G \times V_{GS} \qquad \text{Eq. 7}$$

Where:

C_{ISS} is the total gate capacitance of the MOSFET
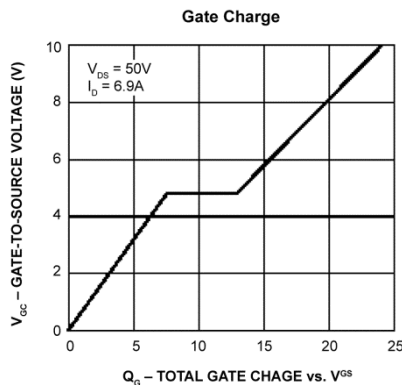
Gate Charge

Figure 7. Typical Gate Charge vs. V_{GS}

The same energy is dissipated by R_{OFF}, R_G, and R_{G_FET} when the driver IC turns the MOSFET off. Assuming R_{ON} is approximately equal to R_{OFF}, the total energy and power dissipated by the resistive drive elements is:

$$E_{DRIVER} = Q_G \times V_{GS}$$

and,

$$P_{DRIVER} = Q_G \times V_{GS} \times f_S$$

Where:

E_{DRIVER} = Energy dissipated per switching cycle.

PDRIVER = Power dissipated by switching the MOSFET on and off.

QG = Total gate charge at VGS.

VGS = the gate-to-source voltage on the MOSFET.

fS = Switching frequency of the gate drive circuit.

The power dissipated inside the MIC4103/4 is equal to the ratio of R_{ON} and R_{OFF} to the external resistive losses in R_G and R_{G_FET}. Letting $R_{ON} = R_{OFF}$, the power dissipated in the MIC4103 due to driving the external MOSFET is:

$$P_{DISS_{DRIVE}} = P_{DRIVER} \frac{R_{ON}}{R_{ON} + R_G + R_{G\_FET}} \qquad \text{Eq. 8}$$

Supply Current Power Dissipation

Power is dissipated in the MIC4103 even if there is nothing being driven. The supply current is drawn by the bias for the internal circuitry, the level shifting circuitry, and shoot-through current in the output drivers. The supply current is proportional to operating frequency and the V_{DD} and V_{HB} voltages. The typical characteristic graphs show how supply current varies with switching frequency and supply voltage.

The power dissipated by the MIC4103 due to supply current is:

$$P_{DISS_{SUPPLY}} = V_{DD} \times I_{DD} + V_{HB} \times I_{HB} \qquad \text{Eq. 9}$$

Total Power Dissipation and Thermal Considerations

Total power dissipation in the MIC4103 or MIC4104 is equal to the power dissipation caused by driving the external MOSFETs, the supply current, and the internal bootstrap diode.

$$P_{DISS_{TOTAL}} = P_{DISS_{SUPPLY}} + P_{DISS_{DRIVE}} + P_{DIODE_{TOTAL}} \qquad \text{Eq. 10}$$

The die temperature may be calculated once the total power dissipation is known.

$$T_J = T_A + P_{DISS_{TOTAL}} \times \theta_{JA}$$ Eq. 11

Where:

T_A = Maximum ambient temperature.

T_J = Junction temperature (°C)

$P_{DISS_{TOTAL}}$ = Power dissipation of the MIC4103/4.

θ_{JC} = Thermal resistance from junction-to-ambient air (°C/W)

Propagation Delay and Delay Matching and other Timing Considerations

Propagation delay and signal timing is an important consideration in a high-performance power supply. The MIC4103 is designed not only to minimize propagation delay but to minimize the mismatch in delay between the high-side and low-side drivers.

Fast propagation delay between the input and output drive waveform is desirable. It improves overcurrent protection by decreasing the response time between the control signal and the MOSFET gate drive. Minimizing propagation delay also minimizes phase shift errors in power supplies with wide bandwidth control loops.

Many power supply topologies use two switching MOSFETs operating 180° out of phase from each other. These MOSFETs must not be on at the same time or a short circuit will occur, causing high peak currents and higher power dissipation in the MOSFETs. The MIC4103 and MIC4104 output gate drivers are not designed with anti-shoot-through protection circuitry. The output drive signals simply follow the inputs. The power supply design must include timing delays (dead-time) between the input signals to prevent shoot-through.

The MIC4103 and MIC4104 drivers specify delay matching between the two drivers to help improve power supply performance by reducing the amount of dead-time required between the input signals.

Care must be taken to insure the input signal pulse width is greater than the minimum specified pulse width. An input signal that is less than the minimum pulse width may result in no output pulse or an output pulse whose width is significantly less than the input.

The maximum duty cycle (ratio of high-side on-time to switching period) is controlled by the minimum pulse width of the low side and by the time required for the C_B capacitor to charge during the off-time.

Adequate time must be allowed for the C_B capacitor to charge up before the high-side driver is turned on.

Decoupling and Bootstrap Capacitor Selection

Decoupling capacitors are required for both the low-side (V_{DD}) and high-side (HB) supply pins. These capacitors supply the charge necessary to drive the external MOSFETs as well as minimize the voltage ripple on these pins. The capacitor from HB to HS serves double duty by providing decoupling for the high-side circuitry as well as providing current to the high-side circuit while the high-side external MOSFET is on. ceramic capacitors are recommended because of their low impedance and small size. Z5U type ceramic capacitor dielectrics are not recommended due to the large change in capacitance over temperature and voltage. A minimum value of 0.1µf is required for each of the capacitors, regardless of the MOSFETs being driven. Larger MOSFETs may require larger capacitance values for proper operation. The voltage rating of the capacitors depends on the supply voltage, ambient temperature, and the voltage derating used for reliability. 25V rated X5R or X7R ceramic capacitors are recommended for most applications. The minimum capacitance value should be increased if low-voltage capacitors are used since even good quality dielectric capacitors, such as X5R, will lose 40% to 70% of their capacitance value at the rated voltage.

Placement of the decoupling capacitors is critical. The bypass capacitor for V_{DD} should be placed as close as possible between the VDD and VSS pins. The bootstrap capacitor (C_B) for the HB supply pin must be located as close as possible between the HB and HS pins. The trace connections must be short, wide, and direct. The use of a ground plane to minimize connection impedance is recommended. Refer to *Grounding, Component Placement, and Circuit Layout* section for more information.

The voltage on the bootstrap capacitor drops each time it delivers charge to turn on the MOSFET. The voltage drop depends on the gate charge required by the MOSFET. Most MOSFET specifications specify gate charge vs. V_{GS} voltage. Based on this information and a recommended ΔV_{HB} of less than 0.1V, the minimum value of bootstrap capacitance is calculated as:

$$C_B \geq \frac{Q_{GATE}}{\Delta V_{HB}}$$ Eq. 12

Where:

Q_{GATE} = Total gate charge at V_{HB}.

Δ_{HB} = Voltage drop at the HB pin.

The decoupling capacitor for the V_{DD} input can be calculated with the same formula; however, the two capacitors are usually equal in value.

Grounding, Component Placement, and Circuit Layout

Nanosecond switching speeds and ampere peak currents in and around the MIC4103 and MIC4104 drivers require proper placement and trace routing of all components. Improper placement may cause degraded noise immunity, false switching, excessive ringing or circuit latch-up.

Figure 8 shows the critical current paths when the driver outputs go high and turn on the external MOSFETs. It also helps demonstrate the need for a low impedance ground plane. Charge needed to turn-on the MOSFET gates comes from the decoupling capacitors C_{VDD} and C_B. Current in the low-side gate driver flows from C_{VDD} through the internal driver, into the MOSFET gate and out the Source. The return connection back to the decoupling capacitor is made through the ground plane. Any inductance or resistance in the ground return path causes a voltage spike or ringing to appear on the source of the MOSFET. This voltage works against the gate drive voltage and can either slow down or turn off the MOSFET during the period where it should be turned on.

Current in the high-side driver is sourced from capacitor C_B and flows into the HB pin and out the HO pin, into the gate of the high side MOSFET. The return path for the current is from the source of the MOSFET and back to capacitor C_B. The high-side circuit return path usually does not have a low impedance ground plane so the trace connections in this critical path should be short and wide to minimize parasitic inductance.

As with the low-side circuit, impedance between the MOSFET source and the decoupling capacitor causes negative voltage feedback which fights the turn-on of the MOSFET.

It is important to note that capacitor CB must be placed close to the HB and HS pins. This capacitor not only provides all the energy for turn-on but it must also keep HB pin noise and ripple low for proper operation of the high-side drive circuitry.
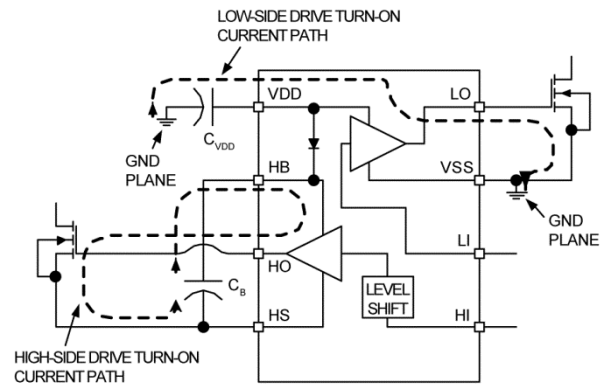

Figure 8. Turn-On Current Paths

Figure 9 shows the critical current paths when the driver outputs go low and turn off the external MOSFETs. Short, low impedance connections are important during turn-off for the same reasons given in the turn-on explanation. Remember that during turn-off current flowing through the internal diode replenishes charge in the bootstrap capacitor (CB).
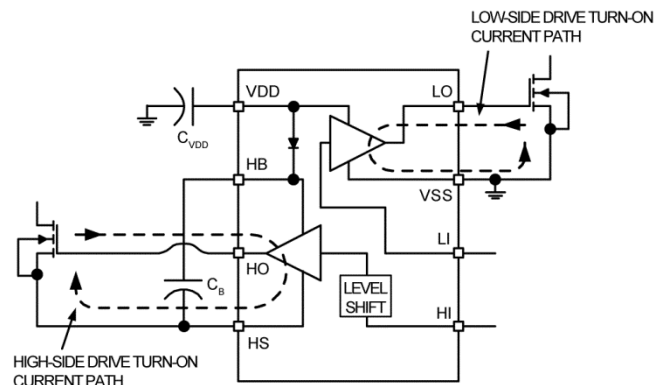

Figure 9. Turn-Off Current Paths

The following circuit guidelines should be adhered to for optimum circuit performance:

1. The V_{DD} and HB bypass capacitors must be placed close to the supply and ground pins. It is critical that the trace length between the high side decoupling capacitor (C_B) and the HB & HS pins be minimized to reduce trace inductance.

2. A ground plane should be used to minimize parasitic inductance and impedance of the return paths. The MIC4103 is capable of greater than 2A peak currents and any impedance between the MIC4103, the decoupling capacitors, and the external MOSFET will degrade the performance of the driver.

3. Trace out the high di/dt and dv/dt paths (as shown in Figure 8 and Figure 9) and minimize trace length and loop area for these connections. Minimizing these parameters decreases the parasitic inductance and the radiated EMI generated by fast rise and fall times.
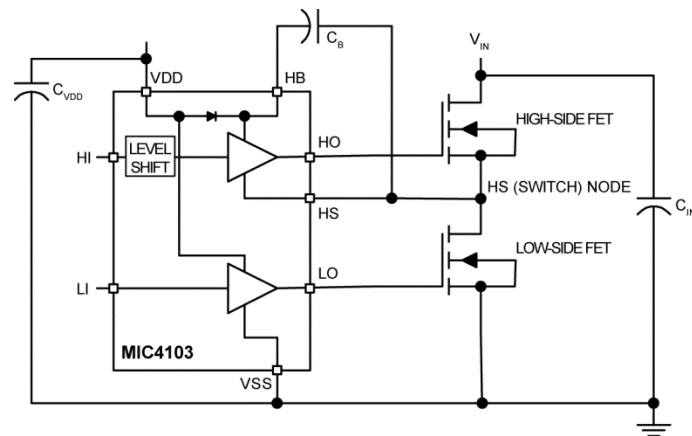
Figure 10. Synchronous Buck Converter Power Stage

A typical layout of a synchronous buck converter power stage (Figure 10) is shown in Figure 11.

The circuit is configured as a synchronous buck power stage. The high-side MOSFET drain connects to the input supply voltage and the source connects to the switching node. The low-side MOSFET drain connects to the switching node and its source is connected to ground. The buck converter output inductor (not shown) would connect to the switching node. The high-side drive trace, HO, is routed on top of its return trace, HS, to minimize loop area and parasitic inductance. The low-side drive trace LO is routed over the ground plane which minimizes the impedance of that current path. The decoupling capacitors, C_B and C_{VDD} are placed to minimize trace length between the capacitors and their respective pins.

This close placement is necessary to efficiently charge capacitor C_B when the HS node is low. All traces are 0.025" wide or greater to reduce impedance. C_{IN} is used to decouple the high current path through the MOSFETs.
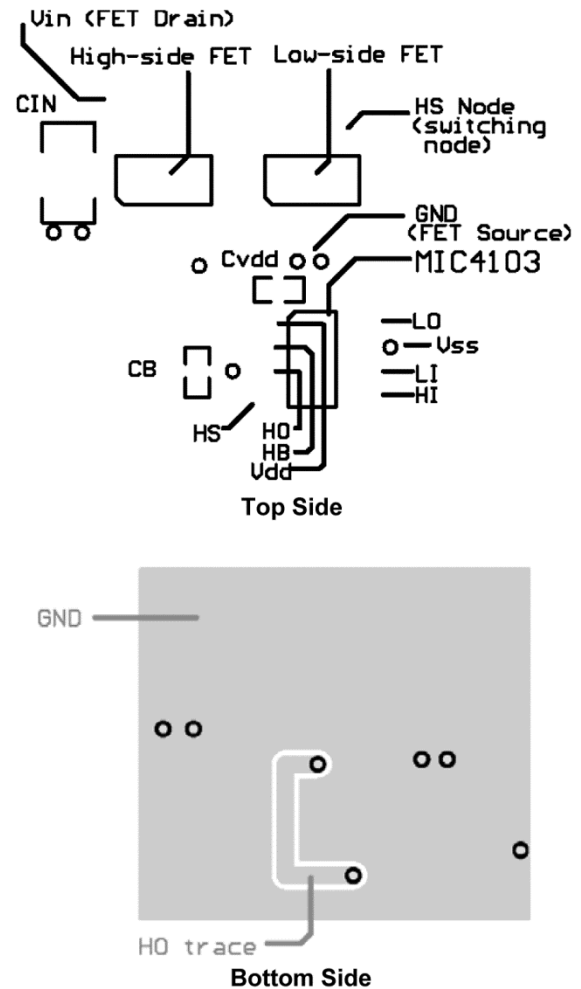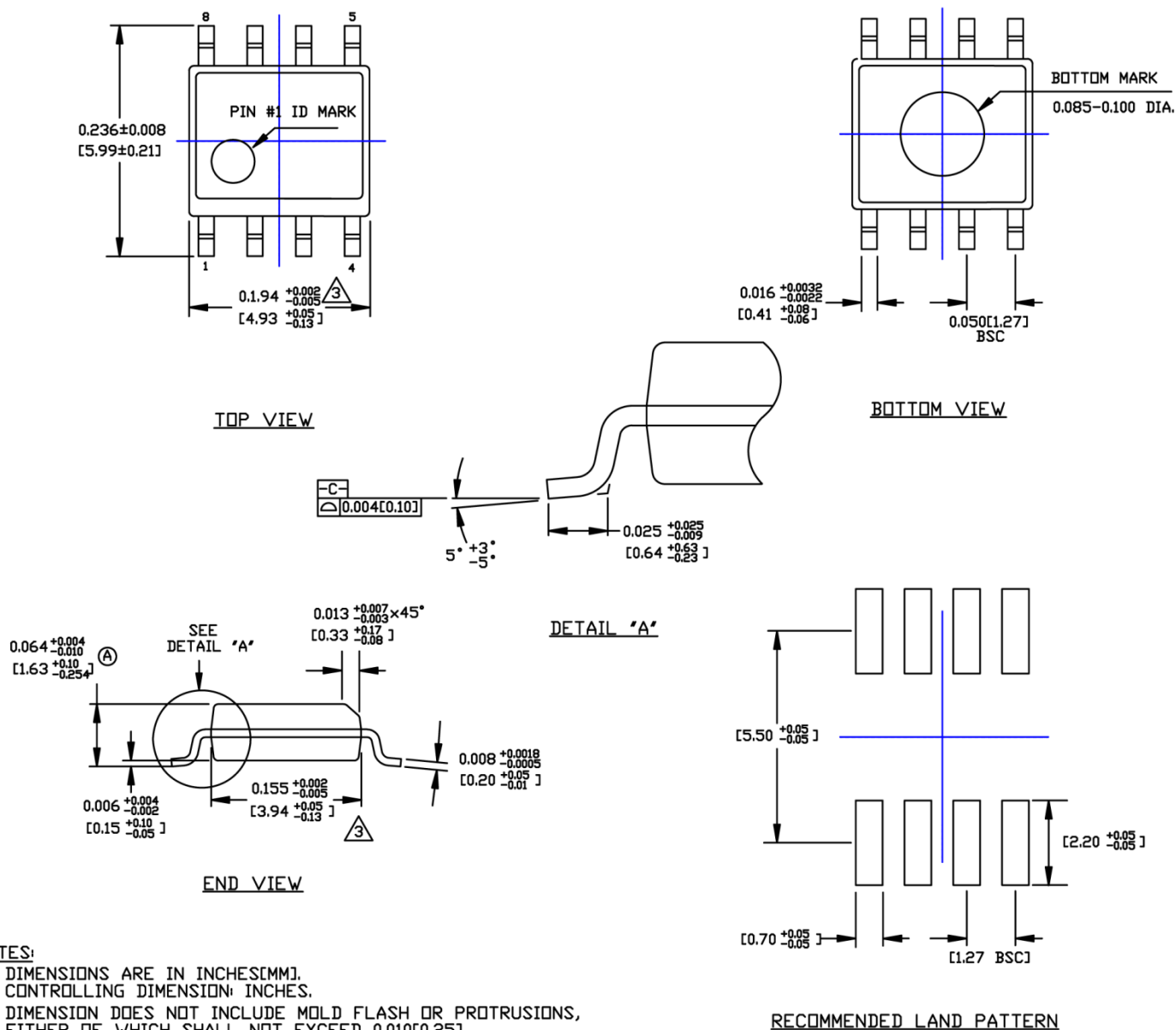

Top Side

Bottom Side

Figure 11. Typical Layout of a Synchronous Buck Converter Power Stage

Package Information and Recommended Landing Pattern[7]

TOP VIEW

0.236±0.008
[5.99±0.21]

PIN #1 ID MARK

8   5

1   4

0.1.94 $^{+0.002}_{-0.005}$ /3\
[4.93 $^{+0.05}_{-0.13}$]

BOTTOM VIEW

BOTTOM MARK
0.085−0.100 DIA.

0.016 $^{+0.0032}_{-0.0022}$
[0.41 $^{+0.08}_{-0.06}$]

0.050[1.27]
BSC

-C-
△ 0.004[0.10]

5° $^{+3°}_{-5°}$

DETAIL "A"

0.025 $^{+0.025}_{-0.009}$
[0.64 $^{+0.63}_{-0.23}$]

END VIEW

0.064 $^{+0.004}_{-0.010}$ (A)
[1.63 $^{+0.10}_{-0.254}$]

SEE
DETAIL "A"

0.013 $^{+0.007}_{-0.003}$×45°
[0.33 $^{+0.17}_{-0.08}$]

0.006 $^{+0.004}_{-0.002}$
[0.15 $^{+0.10}_{-0.05}$]

0.155 $^{+0.002}_{-0.005}$
[3.94 $^{+0.05}_{-0.13}$] /3\

0.008 $^{+0.0018}_{-0.0005}$
[0.20 $^{+0.05}_{-0.01}$]

RECOMMENDED LAND PATTERN

[5.50 $^{+0.05}_{-0.05}$]

[2.20 $^{+0.05}_{-0.05}$]

[0.70 $^{+0.05}_{-0.05}$]

[1.27 BSC]

NOTES:
1. DIMENSIONS ARE IN INCHES[MM].
2. CONTROLLING DIMENSION: INCHES.
/3\ DIMENSION DOES NOT INCLUDE MOLD FLASH OR PROTRUSIONS, EITHER OF WHICH SHALL NOT EXCEED 0.010[0.25] PER SIDE.

8-Pin SOIC (M)

Note:

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